Hybrid IGBT, 50 A, 650 V AFGHL50T65SQDC

Using the novel field stop 4th generation IGBT technology and the 1.5th generation SiC Schottky Diode technology, AFGHL50T65SQDC offers the optimum performance with both low conduction and switching losses for high efficiency operations in various applications, especially totem pole bridgeless PFC and Inverter.

Features

AEC-Q101 Qualified Maximum Junction Temperature : $T_J = 175$ C Positive Temperature Co-efficient for Easy Parallel Operating High Current Capability Low Saturation Voltage: $V_{CE(Sat)} = 1.6$ V (Typ.) @I_C = 50 A Fast Switching Tighten Parameter Distribution No Reverse Recovery/No Forward Recovery

Typical Applications

Automotive On & Off Board Chargers DC–DC Converters PFC Industrial Inverter

MAXIMUM RATINGS

	Rating			Symbol	Value	Unit
Collector to Em	tter Voltage			V _{CES}	650	V
Gate to Emitter Transient Gate		ltage		V _{GES}	20 30	V
Collector Currer	nt	$@T_{C} = 25 C$ $@T_{C} = 100 C$;	Ι _C	100 50	A
Pulsed Collecto	r Current (No	ote 1)		I _{LM}	200	А
Pulsed Collecto	r Current (No	ote 2)		I _{CM}	200070	07 15.30 [°]

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2000707 15.307 ref233.575 263.10 Tc(200)Tj 264.529 .9071001 Tw(Pulswardr Current)re68(

THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit	
Thermal resistance junction-to-case, for IGBT	$R_{ extsf{ heta}JC}$	0.63	C/W	
Thermal resistance junction-to-case, for Diode	$R_{ ext{ heta}JC}$	1.55	C/W	
Thermal resistance junction-to-ambient	$R_{ heta JA}$	40	C/W	

ELECTRICAL CHARACTERISTICS ($T_J = 25$ C unless otherwise noted)

Parameter	Test Conditions	Symbol	Min.	Тур.	Max.	Unit
OFF CHARACTERISTICS						
Collector-emitter breakdown voltage, gate-emitter short-circuited	V _{GE} = 0 V, I _C = 1 mA	BV _{CES}	650	_	-	V
Temperature Coefficient of Breakdown Voltage	V _{GE} = 0 V, I _C = 1 mA	$\frac{\Delta BV_{CES}}{\Delta T_{J}}$	_	,	•	

ELECTRICAL CHARACTERISTICS (T_J = 25 C unless otherwise noted)

Parameter

Unit

TYPICAL CHARACTERISTICS

Figure 1. Typical Output Characteristics $(T_C = 25^{\circ}C)$

Figure 2. Typical Output Characteristics " (T_C = 175°C)



TYPICAL CHARACTERISTICS (continued)

Figure 7. Saturation Voltage vs. V_{GE} (T_C = 175°C)

Figure 8. Capacitance Characteristics

Figure 9. Gate Charge Characteristics ($T_C = 25^{\circ}C$)

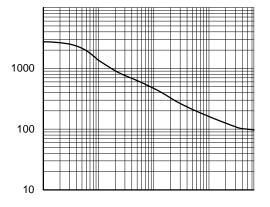
Figure 10. Turn-on Characteristics vs. Gate Resistance

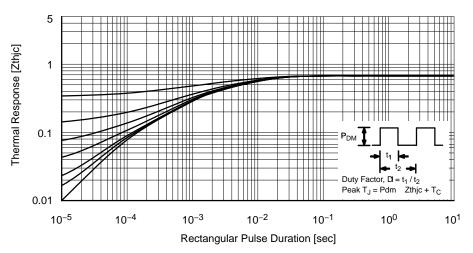
Figure 11. Turn-Off Characteristics vs. Resistance

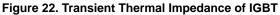
Figure 12. Turn



TYPICAL CHARACTERISTICS (continued)







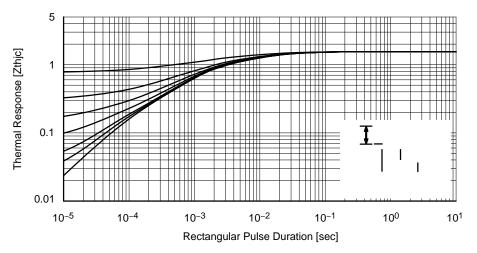
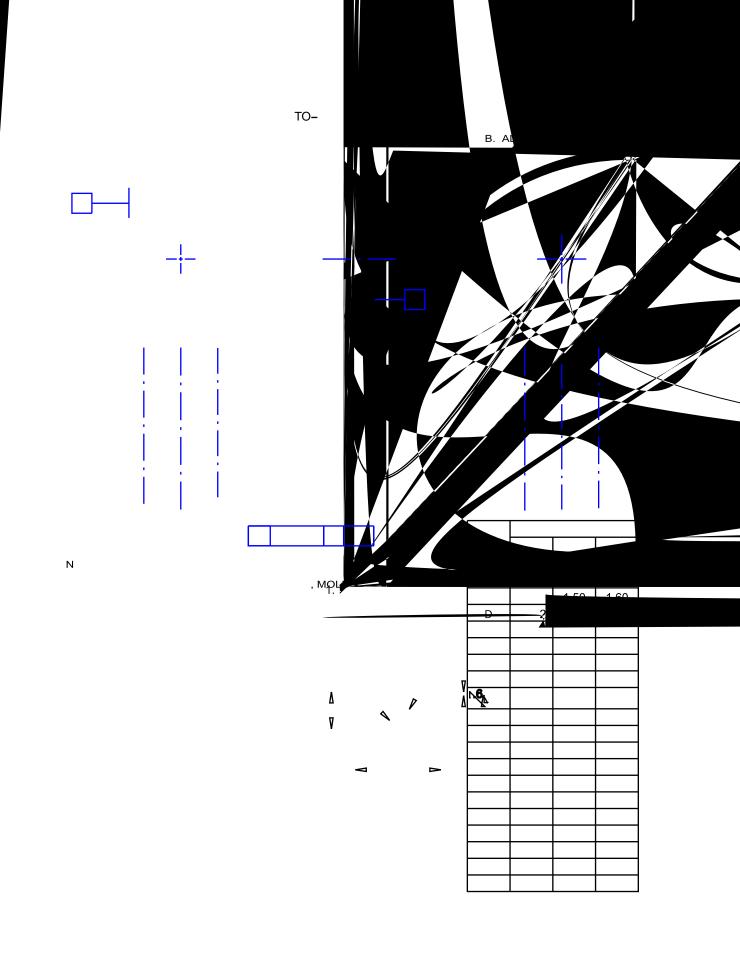


Figure 23. Transient Thermal Impedance of Diode



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